

<b>Notice of References Cited</b>	Application/Control No. 10/634,845	Applicant(s)/Patent Under Reexamination MURAYAMA ET AL.	
	Examiner JEFFREY G. HOEKSTRA	Art Unit 3736	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0023319	09-2001	Miyata et al.	600/462
*	B	US-5,701,911	12-1997	Sasamine et al.	600/585
*	C	US-5,341,817	08-1994	Viera, Fernando M.	600/585
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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